



Shenzhen Asia Test Technology Co., Ltd.

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FCC RADIO TEST REPORT

FCC ID: 2AEWXBUDIUI-BT

Product : budiu smart bluetooth chips

Trade Name : budiu

Model Name : Budiu 2.0 bluetooth

Serial Model : N/A

Prepared for

Beijing ANDL Technology Co., Ltd.
Room 202 BIFTPARK, No.2 East Yinghua Road, Chaoyang District,
Beijing, China

Prepared by

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TEST RESULT CERTIFICATION

Applicant's name Beijing ANDL Technology Co., Ltd.
Address Room 202 BIFTPARK, No.2 East Yinghua Road, Chaoyang
District, Beijing, China

Manufacture's Name Beijing ANDL Technology Co., Ltd.
Address Room 202 BIFTPARK, No.2 East Yinghua Road, Chaoyang
District, Beijing, China

Product description

Product name budiu smart bluetooth chips
Model and/or type Budiu 2.0 bluetooth
reference
Serial Model N/A

Standards FCC Part15.247

Test procedure ANSI C63.4-2003

This device described above has been tested by ATT, and the test results show that the equipment under test (EUT) is in compliance with the FCC requirements. And it is applicable only to the tested sample identified in the report.

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Date of Test

Date (s) of performance of tests May 06, 2015 ~ May 13, 2015

Date of Issue May 13, 2015

Test Result **Pass**

Tested by: Eric Wang
Eric Wang
Project Leader

Reviewed by: Jerry You
Jerry You
Laboratory
Supervisor

Approved by: Jack Yu
Jack Yu
Technical Director

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1. SUMMARY OF TEST RESULTS

Test procedures according to the technical standards:

FCC Part15 (15.247) , Subpart C			
Standard Section	Test Item	Judgment	Remark
15.207	Conducted Emission	N/A	
15.247 (a)(2)	6dB Bandwidth	PASS	
15.247 (b)	Peak Output Power	PASS	
15.247 (c)	Radiated Spurious Emission	PASS	
15.247 (d)	Power Spectral Density	PASS	
15.205	Band Edge Emission	PASS	
15.203	Antenna Requirement	PASS	

NOTE:

(1) "N/A" denotes test is not applicable in this Test Report



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1.1 TEST FACILITY

Asia Institute Technology (DongGuan) Limited
No. 22,JinQianLing Street 3, JiTiGang Village, Huang-Jiang Town, DongGuan, Guangdong,
523757 China
FCC Registration No.: 248337

1.2 MEASUREMENT UNCERTAINTY

The reported uncertainty of measurement $y \pm U$, where expended uncertainty U is based on a standard uncertainty multiplied by a coverage factor of $k=2$, providing a level of confidence of approximately **95 %** .

No.	Item	Uncertainty
1	Conducted Emission Test	$\pm 1.38\text{dB}$
2	RF power,conducted	$\pm 0.16\text{dB}$
3	Spurious emissions,conducted	$\pm 0.21\text{dB}$
4	All emissions,radiated(<1G)	$\pm 4.68\text{dB}$
5	All emissions,radiated(>1G)	$\pm 4.89\text{dB}$
6	Temperature	$\pm 0.5^{\circ}\text{C}$
7	Humidity	$\pm 2\%$



2. GENERAL INFORMATION

2.1 GENERAL DESCRIPTION OF EUT

Equipment	budiu smart bluetooth chips	
Model Name	Budiu 2.0 bluetooth	
Serial Model	N/A	
Model Difference	N/A	
Product Description	The EUT is a budiu smart bluetooth chips	
	Operation Frequency:	2402~2480MHz
	Modulation Type:	GFSK
	Bluetooth version:	4.0
	Bit Rate of Transmitter	1 Mbps
	Number Of Channel	40CH
	Antenna Designation:	Please see Note 3.
	Output Power(Conducted):	-1.18dBm
	Antenna Gain (dBi)	0dbi
Channel List	Please refer to the Note 2.	
Ratings	DC 3V	
Adapter	N/A	
Battery	DC 3V(CR2032)	

Note:

1. For a more detailed features description, please refer to the manufacturer's specifications or the User's Manual.
- 2.

Channel	Frequency (MHz)
00	2402
01	2404
.....	
38	2478
39	2480

- 3.



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Table for Filed Antenna

Ant	Brand	Model Name	Antenna Type	Connector	Gain (dBi)	NOTE
A	N/A	N/A	PCB Antenna	N/A	0	BT Antenna

2.2 DESCRIPTION OF TEST MODES

To investigate the maximum EMI emission characteristics generates from EUT, the test system was pre-scanning tested base on the consideration of following EUT operation mode or test configuration mode which possible have effect on EMI emission level. Each of these EUT operation mode(s) or test configuration mode(s) mentioned above was evaluated respectively.

Pretest Mode	Description
Mode 1	CH00
Mode 2	CH19
Mode 3	CH39

For Conducted Emission	
Final Test Mode	Description
/	/

For Radiated Emission	
Final Test Mode	Description
Mode 1	CH00
Mode 2	CH19
Mode 3	CH39

Note:

- (1) The measurements are performed at the highest, middle, lowest available channels.
the New Battery is used during the measurement.
- (2) The EUT was programmed to be in continuously transmitting mode and the transmit duty cycle is not less than 98%. measurements are performed according to the KDB 558074 D01 DTS Meas Guidance v03r02
- (3) The relevant RF Conducted Measurement is performed by a temporary antenna connector, please refer to the Equipment List for the detail

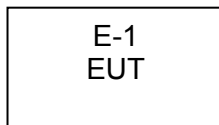


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2.3 BLOCK DIGRAM SHOWING THE CONFIGURATION OF SYSTEM TESTED

Radiated Spurious Emission Test





2.4 DESCRIPTION OF SUPPORT UNITS(CONDUCTED MODE)

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Item	Equipment	Brand	Model/Type No.	Series No.	Note
E-1	budiu smart bluetooth chips	budiu	Budiu 2.0 bluetooth	N/A	EUT

Item	Shielded Type	Ferrite Core	Length	Note

Note:

- (1) The support equipment was authorized by Declaration of Confirmation.
- (2) For detachable type I/O cable should be specified the length in cm in 『Length』 column.
- (3) Conducted RF Anti-lost child measurement used temporary antenna connector.
impedance of the temporary antenna connector is 50ohm,cable loss=0.9db



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2.5 EQUIPMENTS LIST FOR ALL TEST ITEMS

Radiation Test equipment

Item	Kind of Equipment	Manufacturer	Type No.	Serial No.	Last calibration	Calibrated until	Calibration period
1	Test Receiver	R&S	ESR	101160	2014.06.27	2015.06.26	1 year
2	Bilog Antenna	TESEQ	CBL6111D	31216	2014.07.06	2015.07.05	1 year
3	50Ω Coaxial Switch	Anritsu	MP59B	6200264416	2014.06.07	2015.06.06	1 year
4	Horn Antenna	EM	EM-AH-10180	2011071402	2014.07.06	2015.07.05	1 year
5	Horn Ant	Schwarzbeck	BBHA 9170	9170-181	2014.07.06	2015.07.05	1 year
6	Amplifier	EM	EM-30180	060538	2014.12.22	2015.12.21	1 year
7	Loop Antenna	ARA	PLA-1030/B	1029	2014.06.08	2015.06.07	1 year
8	Power Meter	R&S	NRVS	100696	2014.07.06	2015.07.05	1 year
9	Power Sensor	R&S	URV5-Z4	0395.1619.05	2014.07.06	2015.07.05	1 year
10	Cable 1-26GHz	R&S	AIT-R02	201309R048	2014.06.08	2015.06.07	1 year
11	Cable 30-1000MHz	R&S	AIT-R01	201409R047	2014.06.08	2015.06.07	1 year
12	temporary antenna connector	DOKMA	KYS-0944	22550510	2014.06.27	2015.06.26	1 year

note: impedance of the temporary antenna connector is 50ohm, cable loss=0.9db



3. EMC EMISSION TEST

3.1 CONDUCTED EMISSION MEASUREMENT

3.1.1 POWER LINE CONDUCTED EMISSION Limits (Frequency Range 150KHz-30MHz)

FREQUENCY (MHz)	Class A (dBuV)		Class B (dBuV)		Standard
	Quasi-peak	Average	Quasi-peak	Average	
0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *	CISPR
0.50 -5.0	73.00	60.00	56.00	46.00	CISPR
5.0 -30.0	73.00	60.00	60.00	50.00	CISPR

0.15 -0.5	79.00	66.00	66 - 56 *	56 - 46 *	FCC
0.50 -5.0	73.00	60.00	56.00	46.00	FCC
5.0 -30.0	73.00	60.00	60.00	50.00	FCC

Note:

- (1) The tighter limit applies at the band edges.
- (2) The limit of " * " marked band means the limitation decreases linearly with the logarithm of the frequency in the range.

The following table is the setting of the receiver

Receiver Parameters	Setting
Attenuation	10 dB
Start Frequency	0.15 MHz
Stop Frequency	30 MHz
IF Bandwidth	9 kHz



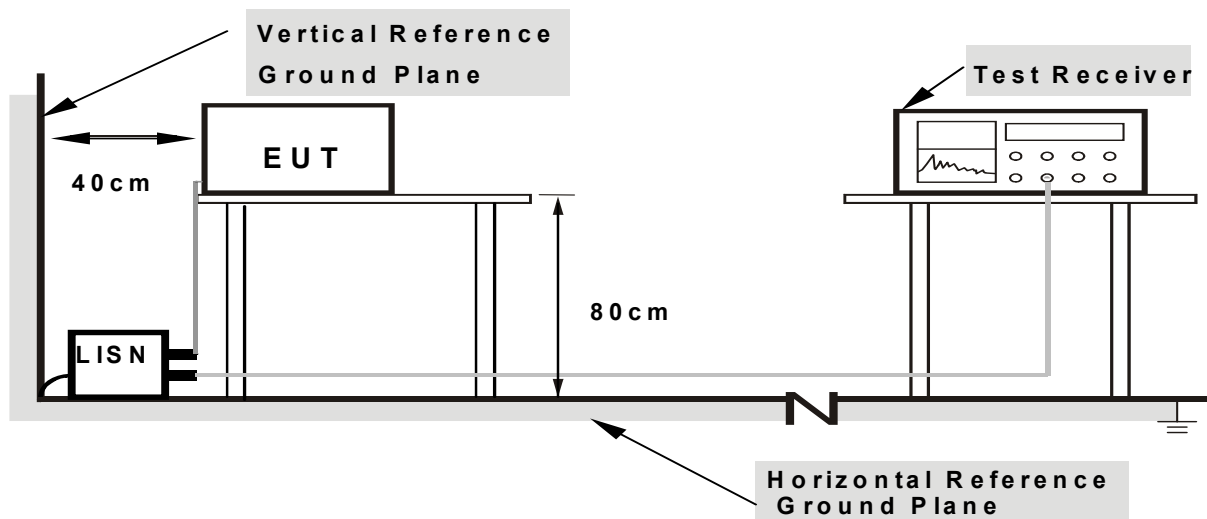
3.1.2 TEST PROCEDURE

- The EUT was placed 0.8 meters from the horizontal ground plane with EUT being connected to the power mains through a line impedance stabilization network (LISN). All other support equipments powered from additional LISN(s). The LISN provide 50 Ohm/ 50uH of coupling impedance for the measuring instrument.
- Interconnecting cables that hang closer than 40 cm to the ground plane shall be folded back and forth in the center forming a bundle 30 to 40 cm long.
- I/O cables that are not connected to a peripheral shall be bundled in the center. The end of the cable may be terminated, if required, using the correct terminating impedance. The overall length shall not exceed 1 m.
- LISN at least 80 cm from nearest part of EUT chassis.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

3.1.3 DEVIATION FROM TEST STANDARD

No deviation

3.1.4 TEST SETUP



Note: 1.Support units were connected to second LISN.

2.Both of LISNs (AMN) are 80 cm from EUT and at least 80
from other units and other metal planes

3.1.5 EUT OPERATING CONDITIONS

The EUT was configured for testing in a typical fashion (as a customer would normally use it). The EUT has been programmed to continuously transmit during test. This operating condition was tested and used to collect the included data.



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3.1.6 TEST RESULTS

Note : Due to this EUT is powered by batteries only, this test item is not applicable.



3.2 RADIATED EMISSION MEASUREMENT

3.2.1 RADIATED EMISSION LIMITS (Frequency Range 9kHz-1000MHz)

20dBc in any 100 kHz bandwidth outside the operating frequency band. In case the emission fall within the restricted band specified on 15.205(a)&A8.5, then the 15.209(a) limit in the table below has to be followed.

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated device is operating, the RF power that is produced shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided that the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of root-mean-square averaging over a time interval, as permitted under Section A8.4 (4), the attenuation required shall be 30 dB instead of 20 dB. Attenuation below the general field strength limits specified in RSS-Gen is not required.

Frequencies (MHz)	Field Strength (micorvolts/meter)	Measurement Distance (meters)
0.009~0.490	2400/F(KHz)	300
0.490~1.705	24000/F(KHz)	30
1.705~30.0	30	30
30~88	100	3
88~216	150	3
216~960	200	3
Above 960	500	3

LIMITS OF RADIATED EMISSION MEASUREMENT (Above 1000MHz)

FREQUENCY (MHz)	Class A (dBuV/m) (at 3M)		Class B (dBuV/m) (at 3M)	
	PEAK	AVERAGE	PEAK	AVERAGE
Above 1000	80	60	74	54

Notes:

(1) Emission level (dBuV/m)=20log Emission level (uV/m).

Spectrum Parameter	Setting
Attenuation	Auto
Start Frequency	1000 MHz
Stop Frequency	10th carrier harmonic
RB / VB (emission in restricted band)	1 MHz / 1 MHz for Peak, 1 MHz / 10Hz for Average



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Receiver Parameter	Setting
Attenuation	Auto
Start ~ Stop Frequency	9kHz~150kHz / RB 200Hz for QP
Start ~ Stop Frequency	150kHz~30MHz / RB 9kHz for QP
Start ~ Stop Frequency	30MHz~1000MHz / RB 120kHz for QP

3.2.2 TEST PROCEDURE

- The measuring distance of at 3 m shall be used for measurements at frequency up to 1GHz. For frequencies above 1GHz, any suitable measuring distance may be used.
- The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter open area test site. The table was rotated 360 degrees to determine the position of the highest radiation.
- The height of the equipment or of the substitution antenna shall be 0.8 m; the height of the test antenna shall vary between 1 m to 4 m. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- The initial step in collecting conducted emission data is a spectrum analyzer peak detector mode pre-scanning the measurement frequency range. Significant peaks are then marked and then Quasi Peak detector mode re-measured.
- If the Peak Mode measured value compliance with and lower than Quasi Peak Mode Limit, the EUT shall be deemed to meet QP Limits and then no additional QP Mode measurement performed.
- For the actual test configuration, please refer to the related Item –EUT Test Photos.

Note:

Both horizontal and vertical antenna polarities were tested
and performed pretest to three orthogonal axis. The worst case emissions were reported

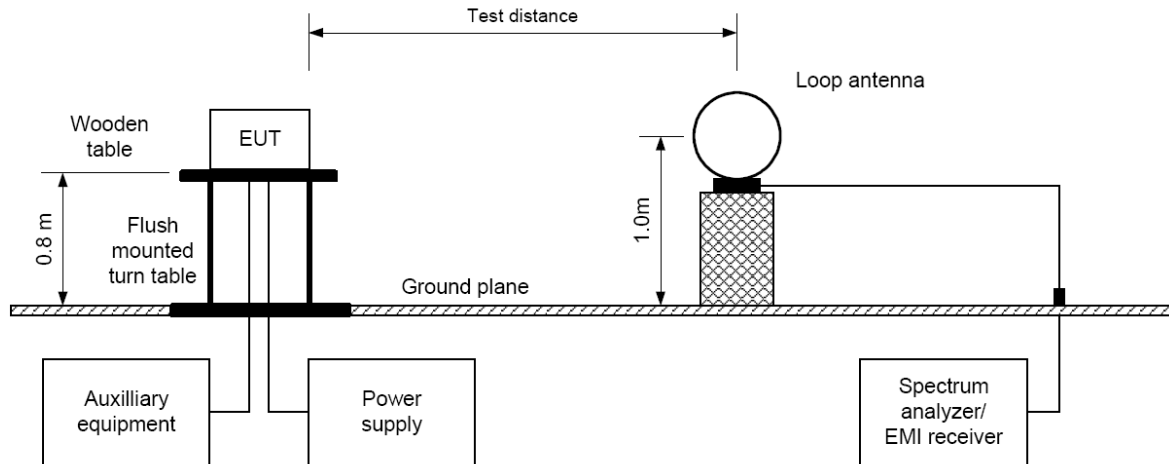
3.2.3 DEVIATION FROM TEST STANDARD

No deviation

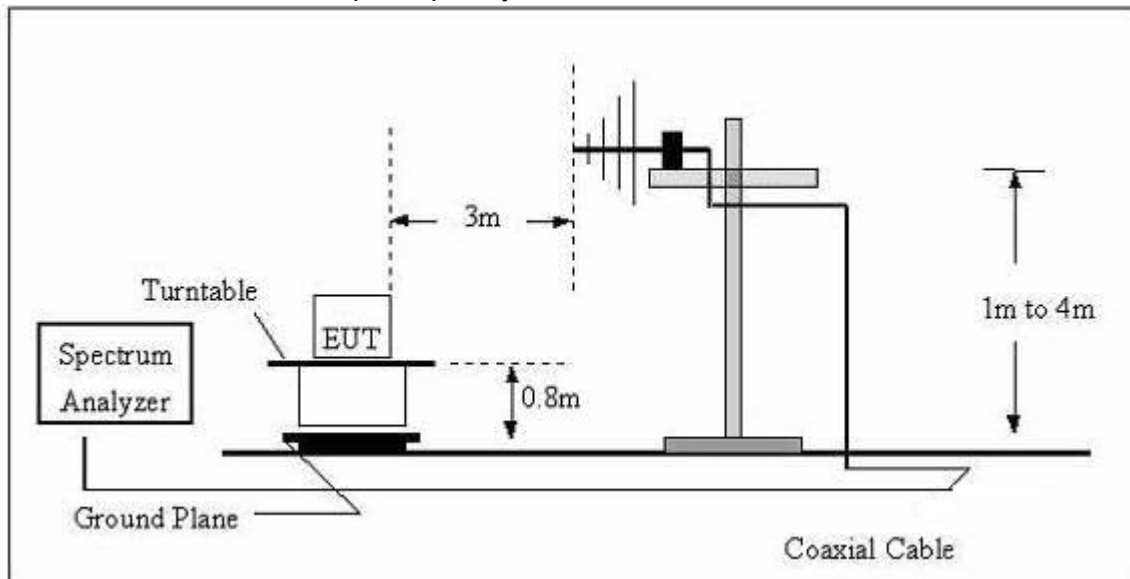


3.2.4 TEST SETUP

(A) Radiated Emission Test-Up Frequency Below 30MHz

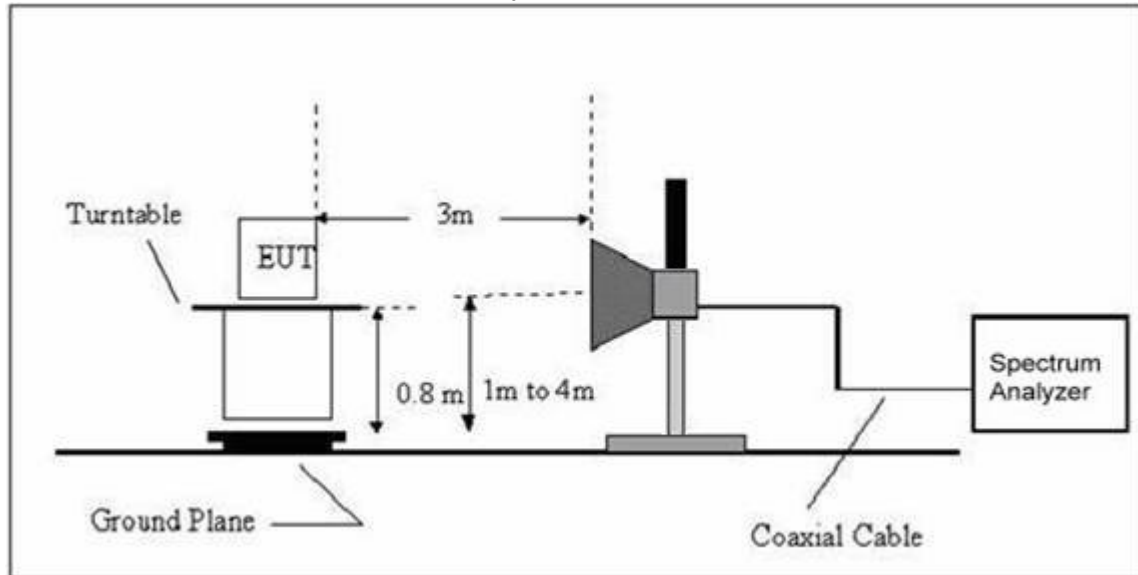


(B) Radiated Emission Test-Up Frequency 30MHz~1GHz





(C) Radiated Emission Test-Up Frequency Above 1GHz



3.2.5 EUT OPERATING CONDITIONS

The EUT tested system was configured as the statements of 2.4 Unless otherwise a special operating condition is specified in the follows during the testing.



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3.2.6 TEST RESULTS (BETWEEN 9KHZ – 30 MHZ)

EUT:	budiu smart bluetooth chips	Model Name. :	Budiu 2.0 bluetooth
Temperature:	20 °C	Relative Humidity:	48%
Pressure:	1010 hPa	Test Voltage :	DC 3V by battery
Test Mode :	TX	Polarization :	--

Freq.	Reading	Limit	Margin	State
(MHz)	(dBuV/m)	(dBuV/m)	(dB)	P/F
--	--	--	--	N/A
--	--	--	--	N/A

NOTE:

The amplitude of spurious emissions which are attenuated by more than 20dB below the permissible value has no need to be reported.

Distance extrapolation factor = $40 \log (\text{specific distance/test distance})$ (dB);

Limit line = specific limits(dBuv) + distance extrapolation factor.



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3.2.7 TEST RESULTS (BETWEEN 30MHZ – 1GHZ)

EUT :	budiu smart bluetooth chips	Model Name :	Budiu 2.0 bluetooth
Temperature :	20 °C	Relative Humidity :	48%
Pressure:	1010 hPa	Test Voltage :	DC 3V by battery
Test Mode :	TX		

Polar (H/V)	Frequency	Meter Reading	Factor	Emission Level	Limits	Margin	Detector Type
	(MHz)	(dBuV)	(dB)	(dBuV/m)	(dBuV/m)	(dB)	
V	53.74	22.63	7.85	30.48	40	-9.52	QP
V	155.27	16.73	9.57	26.3	43.5	-17.2	QP
V	201.55	13.88	11.78	25.66	46	-20.34	QP
V	287.75	14.21	12.28	26.49	46	-19.51	QP
V	325.37	13.47	13.65	27.12	46	-18.88	QP
V	521.84	13.55	16.66	30.21	46	-15.79	QP
H	77.37	13.96	7.86	21.82	40	-18.18	QP
H	185.73	15.73	10.58	26.31	43.5	-17.19	QP
H	249.63	14.52	11.38	25.9	46	-20.1	QP
H	358.63	15.73	14.25	29.98	46	-16.02	QP
H	449.85	14.17	15.47	29.64	46	-16.36	QP
H	616.84	12.47	18.94	31.41	46	-14.59	QP

Remark:

Absolute Level= ReadingLevel+ Factor, Margin= Absolute Level - Limit



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3.2.8 TEST RESULTS (ABOVE 1000 MHZ)

Frequency (MHz)	Reading (dBμV)	Factor (dB)	Corrected Amplitude (dBμV/m)	Limit (dBμV/m)	Margin (dB)	Detector (PK/QP/AV)	Polar (H/V)
Low Channel (2402 MHz)-Above 1G							
4803.78	63.84	-3.64	60.2	74	-13.8	Pk	Vertical
4803.78	54.18	-3.64	50.54	54	-3.46	AV	Vertical
7205.85	60.33	-0.95	59.38	74	-14.62	Pk	Vertical
7205.85	53.84	-0.95	52.89	54	-1.11	AV	Vertical
4804.22	55.37	-3.64	51.73	74	-22.27	Pk	Horizontal
4804.22	47.27	-3.64	43.63	54	-10.37	AV	Horizontal
7206.51	52.75	-0.95	51.8	74	-22.2	Pk	Horizontal
7206.51	40.33	-0.95	39.38	54	-14.62	AV	Horizontal
Mid Channel (2440 MHz)-Above 1G							
4880.54	58.58	-3.68	54.9	74	-19.1	Pk	Vertical
4880.54	50.83	-3.68	47.15	54	-6.85	AV	Vertical
7320.37	61.48	-0.82	60.66	74	-13.34	Pk	Vertical
7320.37	50.44	-0.82	49.62	54	-4.38	AV	Vertical
4880.19	57.29	-3.68	53.61	74	-20.39	Pk	Horizontal
4880.19	44.73	-3.68	41.05	54	-12.95	AV	Horizontal
7320.68	50.74	-0.82	49.92	74	-24.08	Pk	Horizontal
7320.68	39.84	-0.82	39.02	54	-14.98	AV	Horizontal
High Channel (2480MHz)- Above 1G							
4960.55	62.47	-3.59	58.88	74	-15.12	Pk	Vertical
4960.55	50.62	-3.59	47.03	54	-6.97	AV	Vertical
7440.24	59.74	-0.69	59.05	74	-14.95	Pk	Vertical
7440.24	48.73	-0.69	48.04	54	-5.96	AV	Vertical
4960.31	58.63	-3.59	55.04	74	-18.96	Pk	Horizontal
4960.31	46.58	-3.59	42.99	54	-11.01	AV	Horizontal
7440.49	55.24	-0.69	54.55	74	-19.45	Pk	Horizontal
7440.49	42.47	-0.69	41.78	54	-12.22	AV	Horizontal

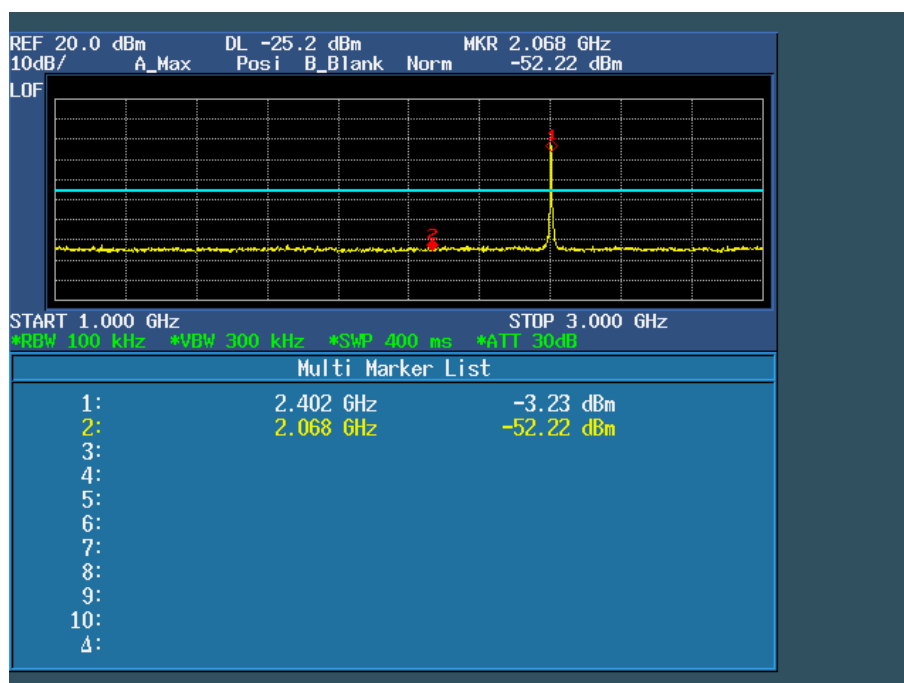
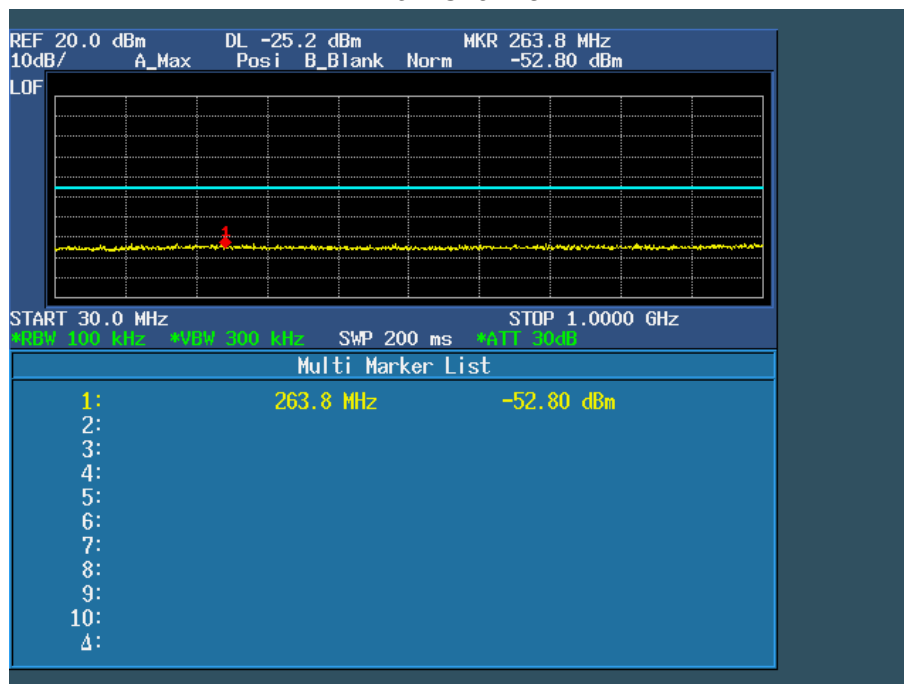


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Conducted Spurious Emissions at Antenna Port:

Low Channel

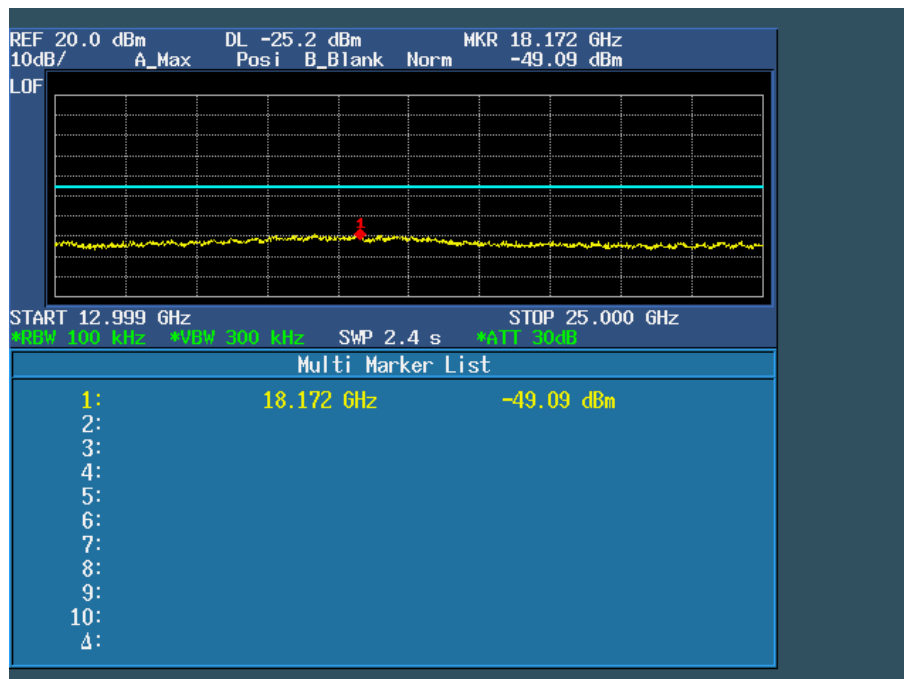
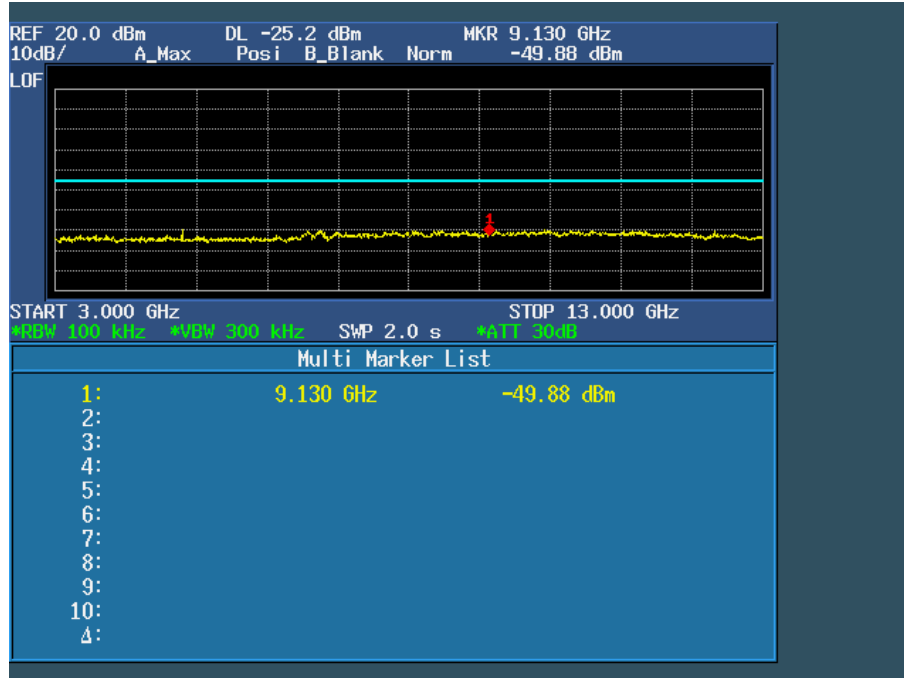




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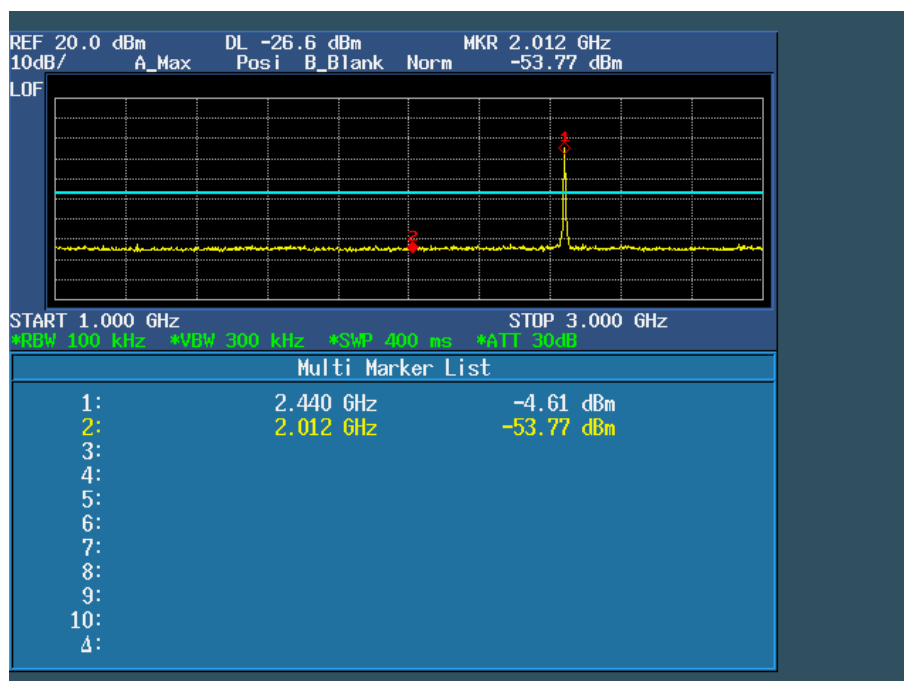
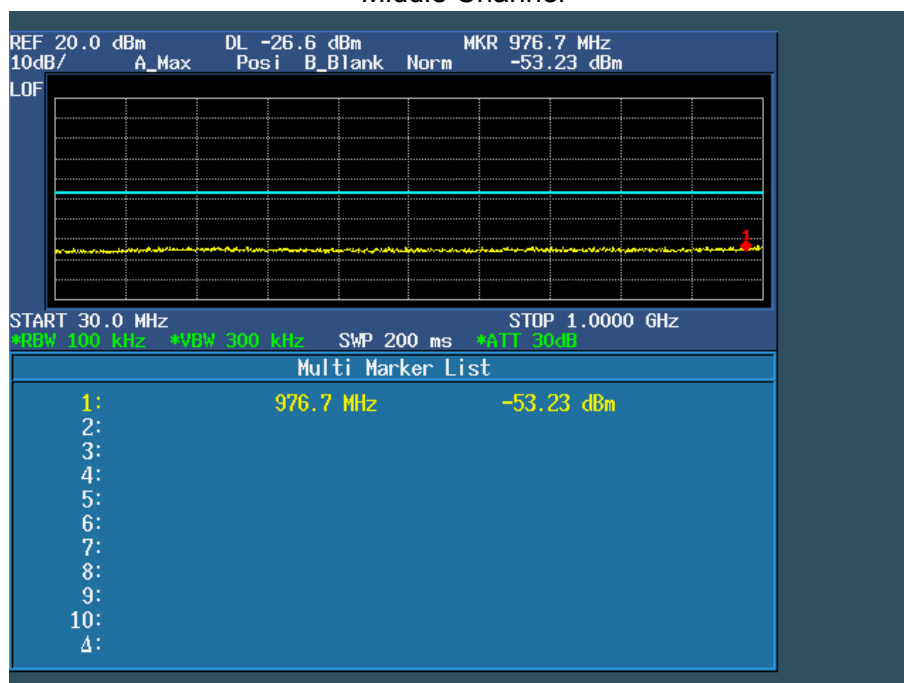




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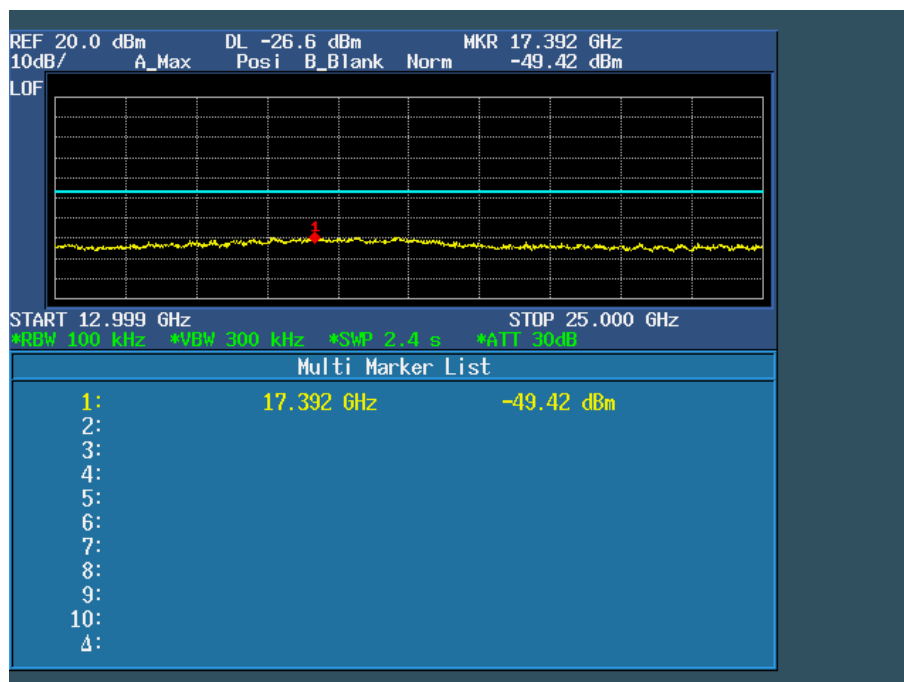
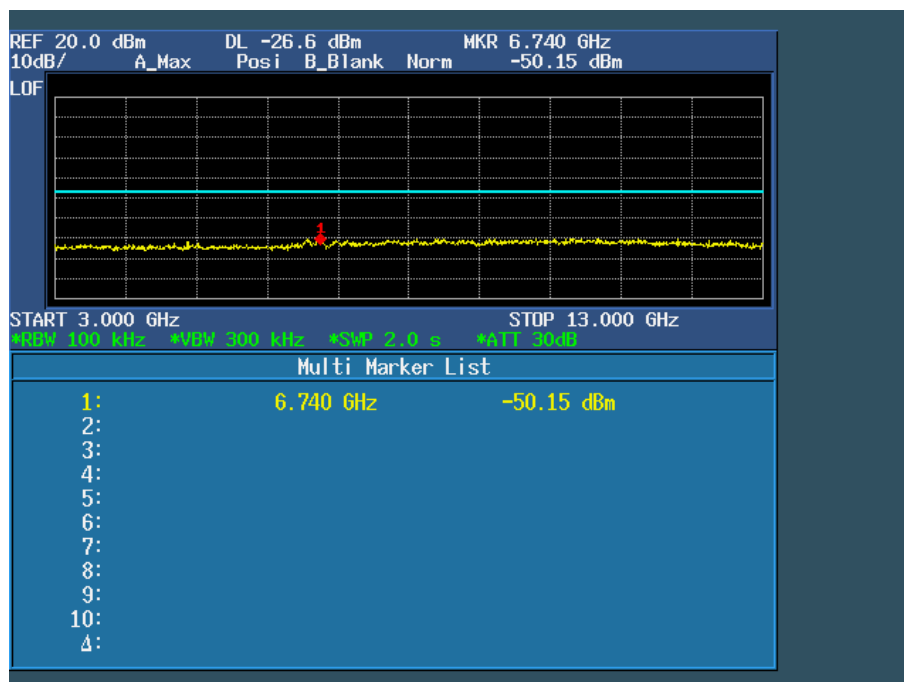
Middle Channel





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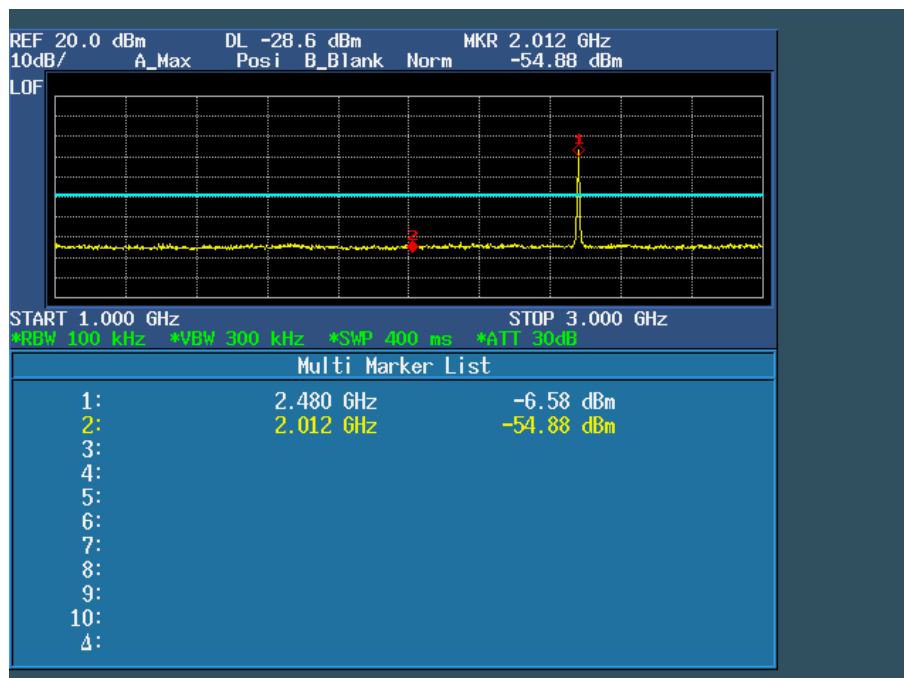
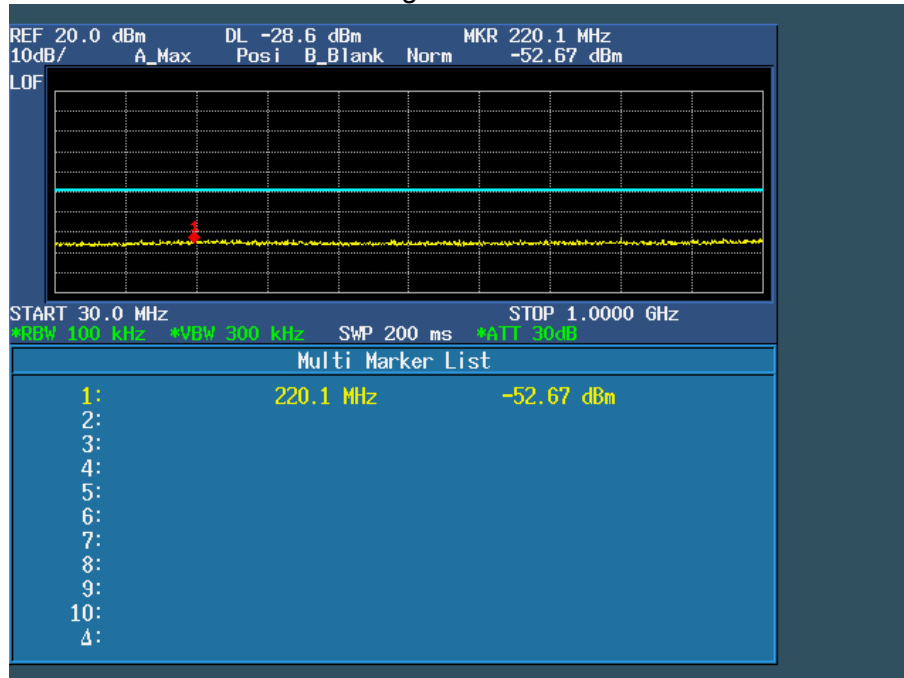


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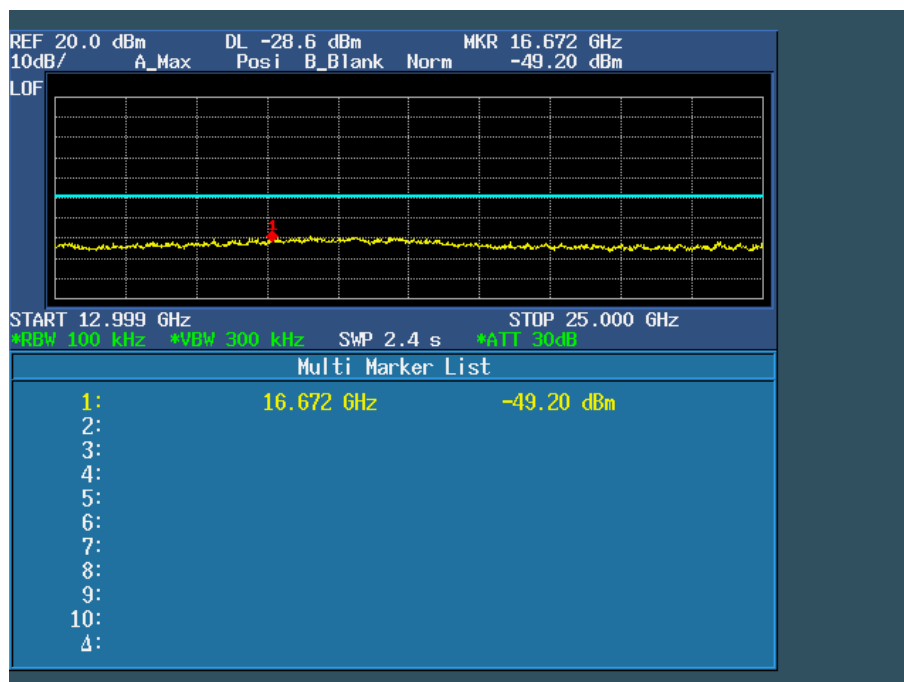
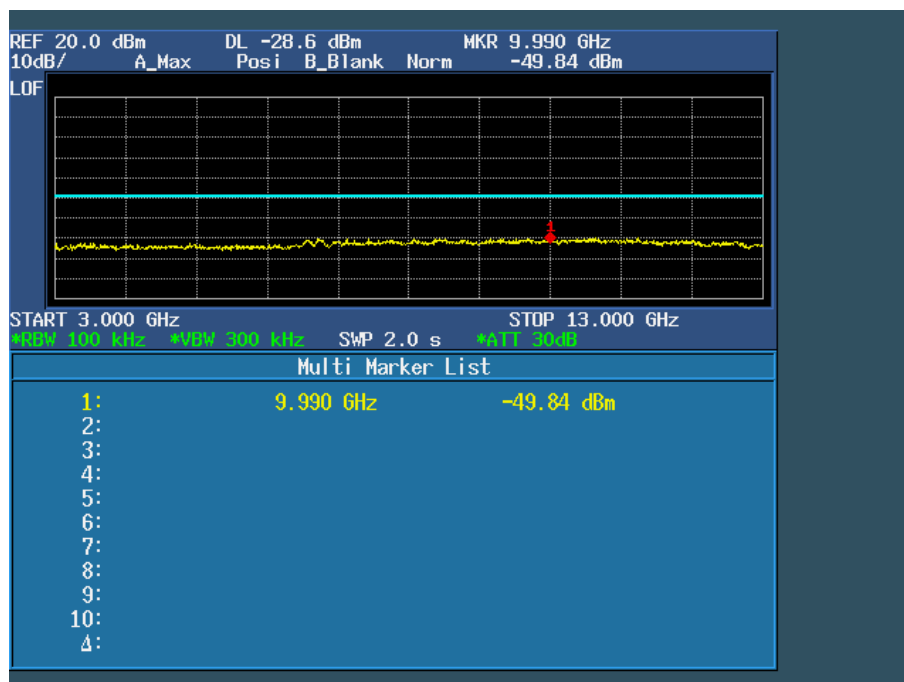
High Channel





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4. POWER SPECTRAL DENSITY TEST

4.1 APPLIED PROCEDURES / LIMIT

FCC Part15 (15.247) , Subpart C&A8.2				
Section	Test Item	Limit	Frequency Range (MHz)	Result
15.247&A8.2	Power Spectral Density	8 dBm (in any 3KHz)	2400-2483.5	PASS

4.1.1 TEST PROCEDURE

1. Set analyzer center frequency to DTS channel center frequency.
2. Set the span to 1.5 times the DTS channel bandwidth.
3. Set the RBW ≥ 3 kHz.
4. Set the VBW $\geq 3 \times$ RBW.
5. Detector = peak.
6. Sweep time = auto couple.
7. Trace mode = max hold.
8. Allow trace to fully stabilize.
9. Use the peak marker function to determine the maximum amplitude level.
10. If measured value exceeds limit, reduce RBW (no less than 3 kHz) and repeat.

4.1.2 DEVIATION FROM STANDARD

No deviation.

4.1.3 TEST SETUP



4.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 2.1 Unless otherwise a special operating condition is specified in the follows during the testing.



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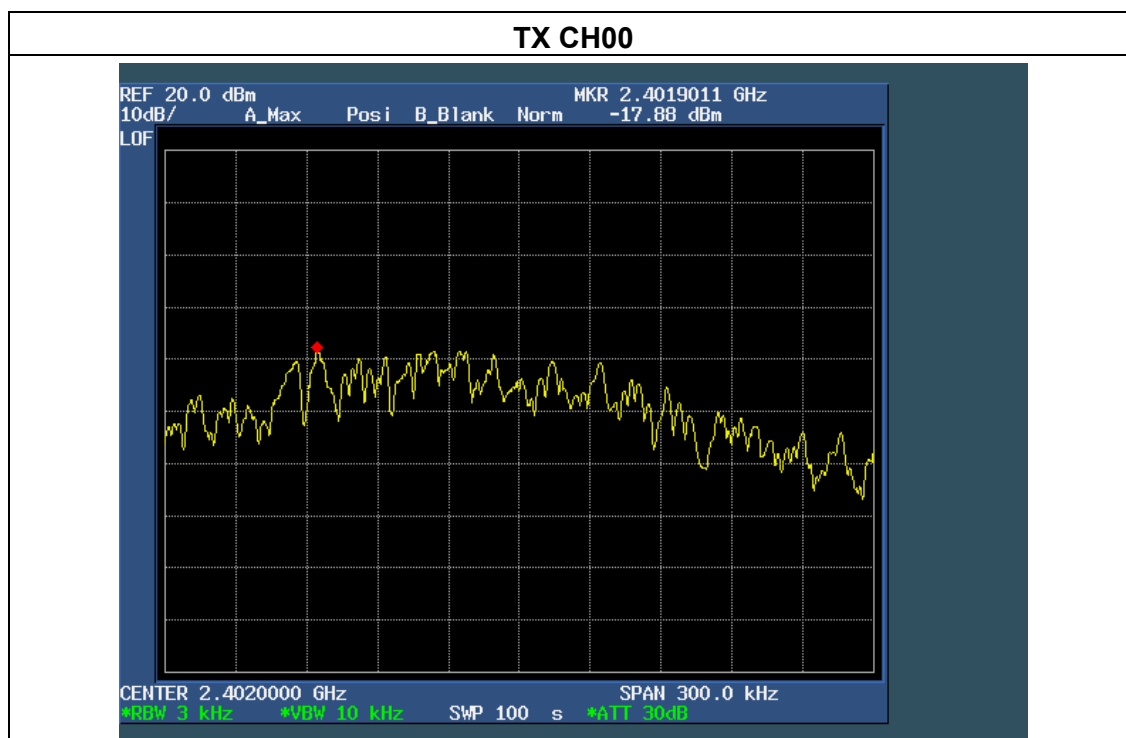
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4.1.5 TEST RESULTS

EUT :	budiu smart bluetooth chips	Model Name :	Budiu 2.0 bluetooth
Temperature :	25 °C	Relative Humidity :	56%
Pressure :	1015 hPa	Test Voltage :	DC 3V
Test Mode :	TX Mode /CH00, CH19, CH39		

Note: The relevant measured result has the offset with cable loss already.

Frequency	Power Density (dBm/3kHz)	Limit (dBm/3kHz)	Result
2402 MHz	-17.88	8	PASS
2440 MHz	-15.94	8	PASS
2480 MHz	-16.14	8	PASS

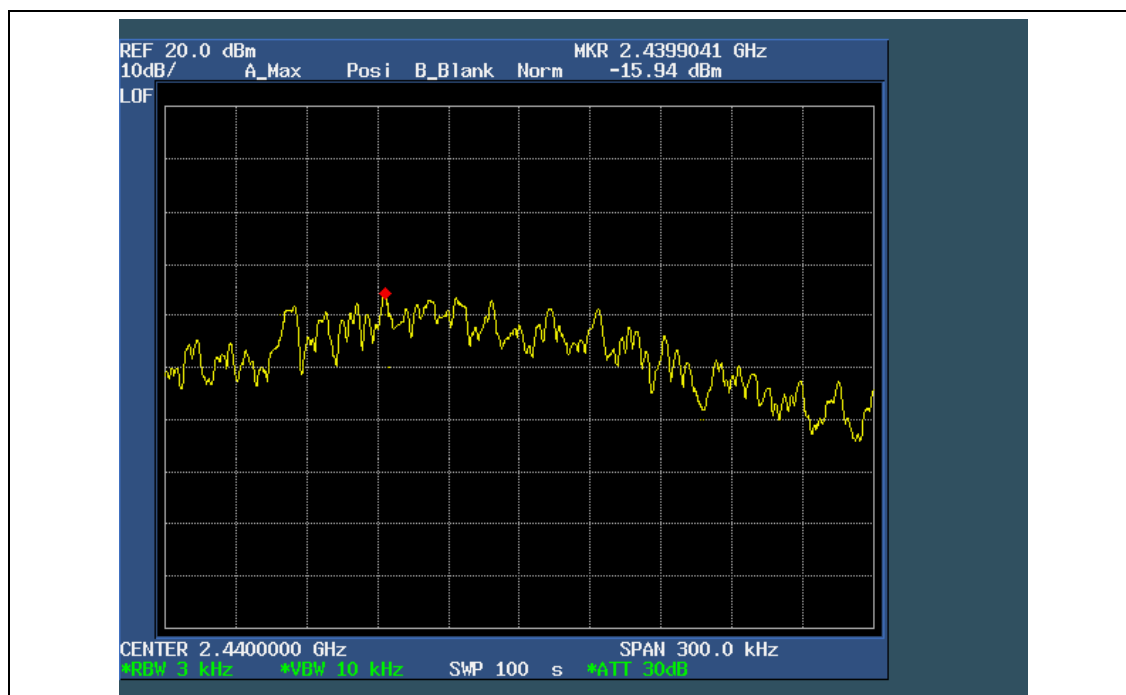


TX CH19

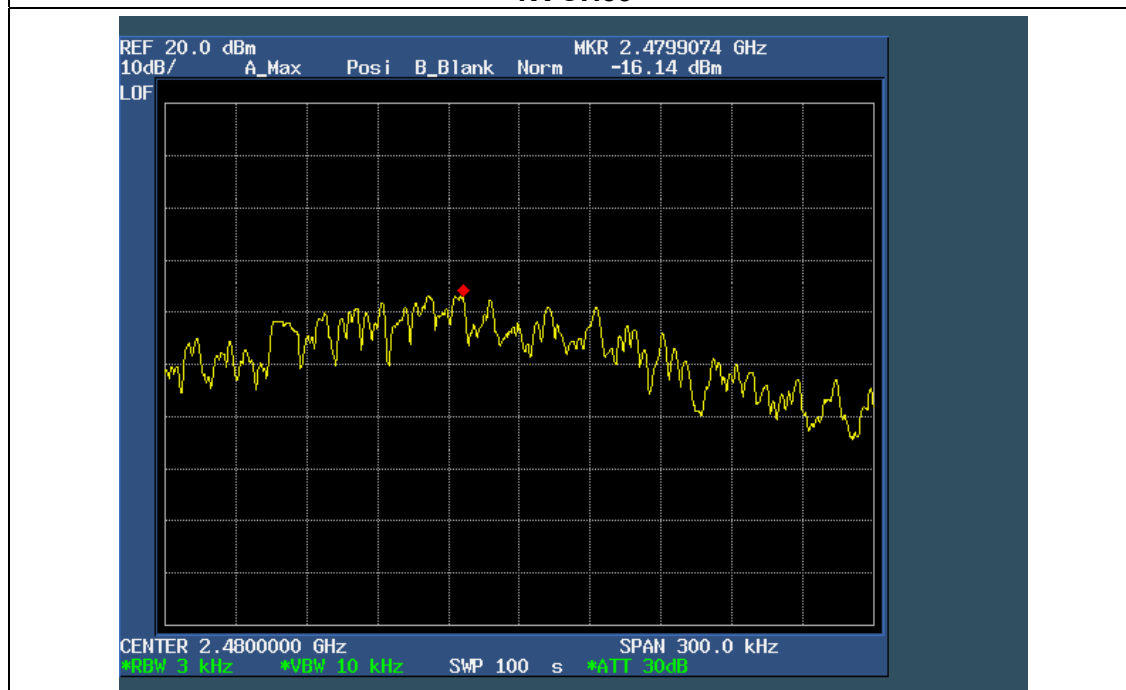


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TX CH39





5. BANDWIDTH TEST

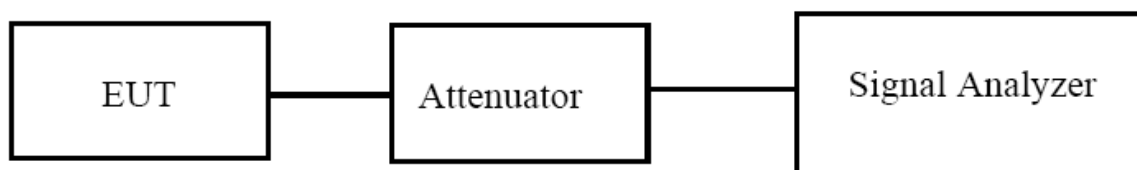
5.1 APPLIED PROCEDURES / LIMIT

FCC Part15 (15.247) , Subpart C&A8.2				
Section	Test Item	Limit	Frequency Range (MHz)	Result
15.247(a)(2) &A8.2	Bandwidth	$\geq 500\text{KHz}$ (6dB bandwidth)	2400-2483.5	PASS

5.1.1 TEST PROCEDURE

According to KDB 558074 D01 DTS Meas Guidance v03r02

1. Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator
2. Position the EUT without connection to measurement instrument. Turn on the EUT and connect it to measurement instrument. Then set it to any one convenient frequency within its operating range. Set a reference level on the measuring instrument equal to the highest peak value.
3. Measure the frequency difference of two frequencies that were attenuated 6 dB from the reference level. Record the frequency difference as the emission bandwidth.
4. Repeat above procedures until all frequencies measured were complete.



5.1.2 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 2.4 Unless otherwise a special operating condition is specified in the follows during the testing.



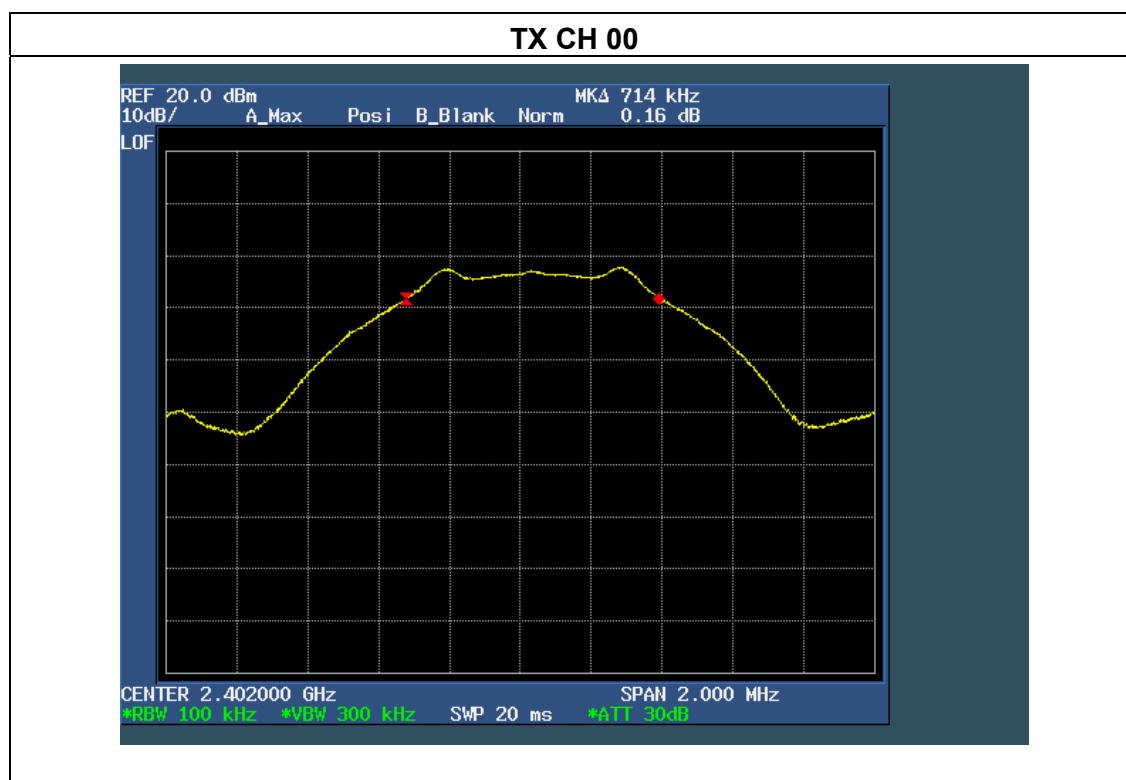
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5.1.3 TEST RESULTS

EUT :	budiu smart bluetooth chips	Model Name :	Budiu 2.0 bluetooth
Temperature :	25 °C	Relative Humidity :	56%
Pressure :	1012 hPa	Test Voltage :	DC 3V
Test Mode :	TX Mode /CH00, CH19, CH39		

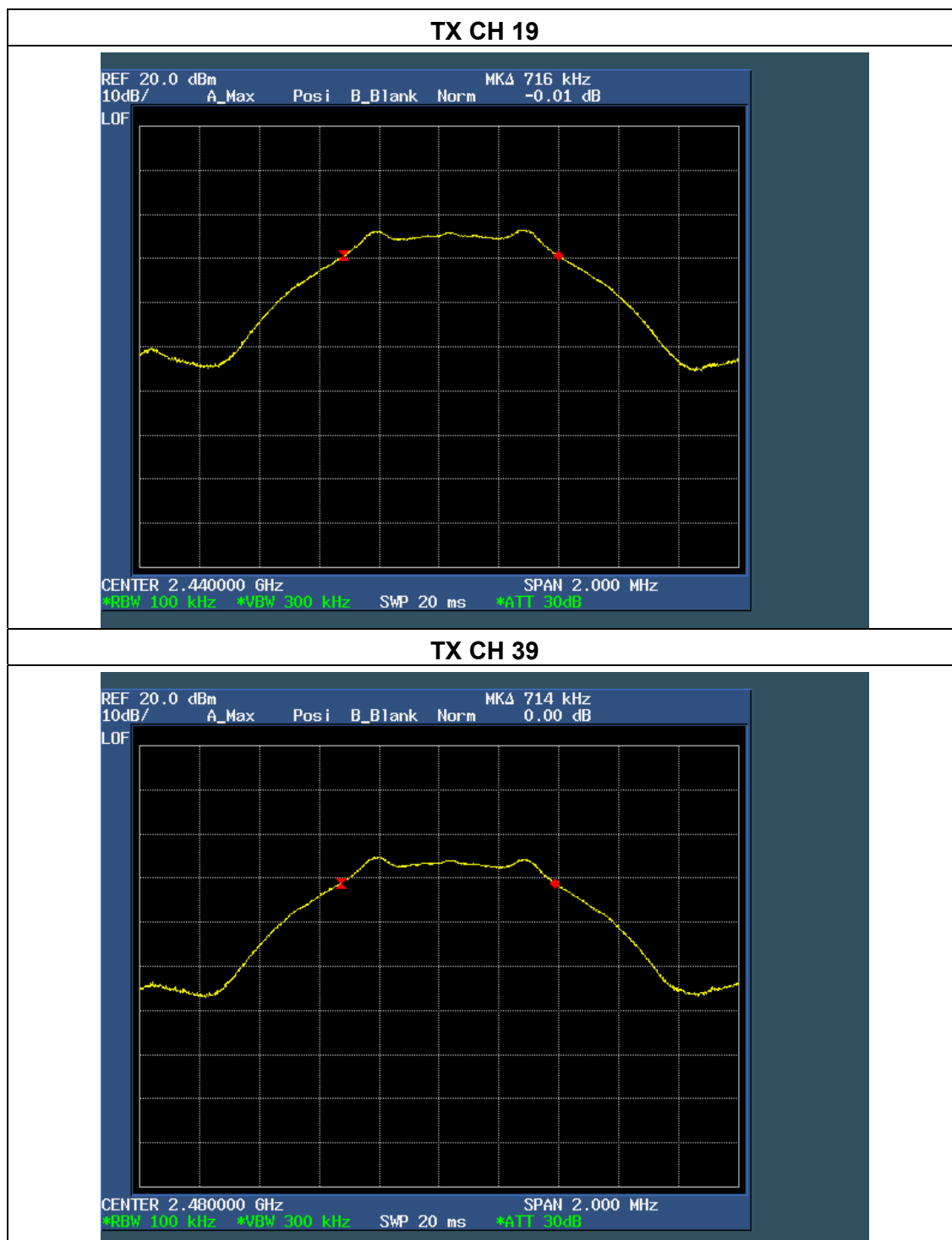
Channel	Frequency (MHz)	6dB bandwidth (kHz)	99% bandwidth (MHz)	Limit (kHz)	Result
Low	2402	714	/	>500	Pass
Middle	2440	716	/	>500	Pass
High	2480	714	/	>500	Pass





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6. PEAK OUTPUT POWER TEST

6.1 APPLIED PROCEDURES / LIMIT

FCC Part15 (15.247) , Subpart C &A8.4				
Section	Test Item	Limit	Frequency Range (MHz)	Result
15.247(b)(3) &A8.4	Peak Output Power	1 watt or 30dBm	2400-2483.5	PASS

6.1.1 TEST PROCEDURE

- a. The EUT was directly connected to the Power meter

6.1.2 DEVIATION FROM STANDARD

No deviation.

6.1.3 TEST SETUP



6.1.4 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 2.4 Unless otherwise a special operating condition is specified in the follows during the testing.



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6.1.5 TEST RESULTS

EUT :	budiu smart bluetooth chips	Model Name :	Budiu 2.0 bluetooth
Temperature :	25 °C	Relative Humidity :	60%
Pressure :	1012 hPa	Test Voltage :	DC 3V
Test Mode :	TX Mode		

TX Mode			
Test Channe	Frequency	Maximum Conducted Output Power (PK)	LIMIT
	(MHz)	(dBm)	dBm
CH00	2402	-1.47	30
CH19	2440	-1.18	30
CH39	2480	-1.22	30



7. 100 KHZ BANDWIDTH OF FREQUENCY BAND EDGE

APPLICABLE STANDARD

In any 100 kHz bandwidth outside the frequency band in which the spread spectrum or digitally modulated intentional radiator is operating, the radio frequency power that is produced by the intentional radiator shall be at least 20 dB below that in the 100 kHz bandwidth within the band that contains the highest level of the desired power, based on either an RF conducted or a radiated measurement, provided the transmitter demonstrates compliance with the peak conducted power limits. If the transmitter complies with the conducted power limits based on the use of RMS averaging over a time interval, as permitted under paragraph (b)(3) of this section, the attenuation required under this paragraph shall be 30 dB instead of 20 dB. Attenuation below the general limits specified in §15.209(a)&A1.1 is not required. In addition, radiated emissions which fall in the restricted bands, as defined in §15.205(a)&A8.5, must also comply with the radiated emission limits specified in §15.209(a) &A1.1 (see §15.205(c)) &A8.5.

TEST PROCEDURE

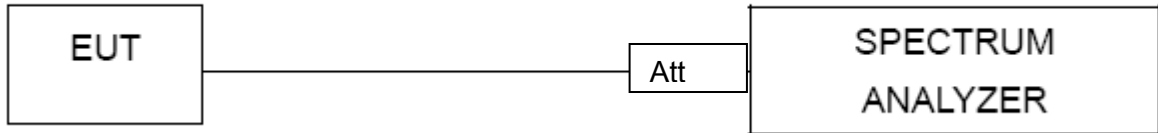
- a) Check the calibration of the measuring instrument using either an internal calibrator or a known signal from an external generator.
- b) Position the EUT without connection to measurement instrument. Turn on the EUT and connect its antenna terminal to measurement instrument via a low loss cable. Then set it to any one measured frequency within its operating range, and make sure the instrument is operated in its linear range.
- c) Set RBW to 100 kHz and VBW of spectrum analyzer to 300 kHz with a convenient frequency span including 100 kHz bandwidth from band edge.
- d) Measure the highest amplitude appearing on spectral display and set it as a reference level. Plot the graph with marking the highest point and edge frequency.
- e) Repeat above procedures until all measured frequencies were complete.

7.1 DEVIATION FROM STANDARD

No deviation.



7.2 TEST SETUP



7.3 EUT OPERATION CONDITIONS

The EUT tested system was configured as the statements of 2.4 Unless otherwise a special operating condition is specified in the follows during the testing.



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7.4 TEST RESULTS

EUT :	budiu smart bluetooth chips	Model Name :	Budiu 2.0 bluetooth
Temperature :	25 °C	Relative Humidity :	56%
Pressure :	1012 hPa	Test Voltage :	DC 3V

Frequency Band	Delta Peak to band emission (dBc)	> Limit (dBc)	Result
Left-band	28.30	20	Pass
Right-band	43.66	20	Pass

Frequency (MHz)	Meter Reading (dBμV)	Factor (dB)	Emission Level (dBμV/m)	Limits (dBμV/m)	Margin (dB)	Detector Type	Comment
2390	60.27	-12.65	47.62	74	-26.38	peak	Vertical
2390	61.32	-12.65	48.67	74	-25.33	peak	Horizontal
2483.5	59.77	-12.12	47.65	74	-26.35	peak	Vertical
2483.5	58.84	-12.12	46.72	74	-27.28	peak	Horizontal

Note: Test method to see chapter 3.2 . When PK value is lower than the Average value limit, average not record.



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Band Edge, Left Side





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Band Edge, Right Side





8. ANTENNA REQUIREMENT

8.1 STANDARD REQUIREMENT

15.203 requirement: For intentional device, according to 15.203: an intentional radiator shall be designed to ensure that no antenna other than that furnished by the responsible party shall be used with the device.

8.2 EUT ANTENNA

The EUT antenna is PCB antenna. It comply with the standard requirement.



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9. EUT TEST PHOTO

Radiated Measurement Photos

